Search Notes



Application	n/Control	No.

Applicant(s)/Patent under Reexamination OGUSHI ET AL. Art Unit

10/645,578 Examiner

2861

Huan	ы	Tran
nuan	П.	Han

SEARCHED					
Class	Subclass	Date	Examiner		
347	222	4/29/2005	ннт		
347	263	4/29/2005	ннт		
347	108	4/29/2005	ннт		
-					

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
222	4/29/2005	ннт		
263	4/29/2005	ннт		
	Subclass 222	Subclass Date 222 4/29/2005		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	4/29/2005	ннт	
-			